DISCRETE SEMICONDUCTORS

DATA SHEET

BTA225 series B Three quadrant triacs high commutation

Product specification

September 1997



NXP Semiconductors Product specification

Three quadrant triacs high commutation

BTA225 series B

GENERAL DESCRIPTION

Glass passivated high commutation triacs in a plastic envelope intended for use in circuits where high static and dynamic dV/dt and high dl/dt can occur loads. These devices will commutate the full rated rms current at the maximum rated junction temperature, without the aid of a snubber.

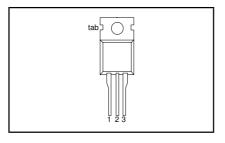
QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	MAX.	MAX.	UNIT
V _{DRM} I _{T(RMS)} I _{TSM}	BTA225- Repetitive peak off-state voltages RMS on-state current Non-repetitive peak on-state current	500B 500 25 190	600B 600 25 190	800B 800 25 190	V A A

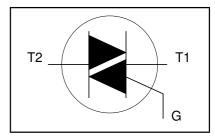
PINNING - TO220AB

PIN	PIN DESCRIPTION		
1	main terminal 1		
2	main terminal 2		
3	gate		
tab	main terminal 2		

PIN CONFIGURATION



SYMBOL



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.		UNIT	
				-500	-600	-800	
V_{DRM}	Repetitive peak off-state voltages		-	600¹	600¹	800	V
I _{T(RMS)}	RMS on-state current	full sine wave;	-		25		Α
I _{TSM}	Non-repetitive peak on-state current	$T_{mb} \le 91$ °C full sine wave; $T_j = 25$ °C prior to surge					
		t = 20 ms t = 16.7 ms	-		190 209		A
l²t dl _⊤ /dt	l ² t for fusing Repetitive rate of rise of on-state current after	t = 10.7 m/s t = 10 m/s $I_{TM} = 30 \text{ A}; I_G = 0.2 \text{ A};$ $dI_G/dt = 0.2 \text{ A}/\mu\text{s}$	-		180 100		A A²s A/μs
$\begin{matrix} I_{GM} \\ V_{GM} \\ P_{GM} \\ P_{G(AV)} \end{matrix}$	triggering Peak gate current Peak gate voltage Peak gate power Average gate power	over any 20 ms	- - -		2 5 5 0.5		A V W W
$T_{stg} \ T_{j}$	Storage temperature Operating junction temperature	period	-40 -		150 125		ŷ

September 1997 2 Rev 1.200

¹ Although not recommended, off-state voltages up to 800V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 $A/\mu s$.

NXP Semiconductors Product specification

Three quadrant triacs high commutation

BTA225 series B

THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
	Thermal resistance junction to mounting base	full cycle half cycle	-		1.0 1.4	K/W K/W
$R_{th j-a}$	Thermal resistance junction to ambient	in free air	-	60	-	K/W

STATIC CHARACTERISTICS

 $T_i = 25$ °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS		MIN.	TYP.	MAX.	UNIT
I _{GT}	Gate trigger current ²	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$					
G1			T2+ G+	2	18	50	mA
			T2+ G-	2	21	50	mΑ
			T2- G-	2 2	34	50	mΑ
I_{L}	Latching current	$V_D = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$					
-		7 41	T2+ G+	-	31	60	mA
			T2+ G-	-	34	90	mA
			T2- G-	-	30	60	mA
I_{H}	Holding current	$V_D = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$		-	31	60	mA
V_T	On-state voltage	$I_{T} = 30 \text{ A}$		-	1.3	1.55	V
V_{GT}	Gate trigger voltage	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$		-	0.7	1.5	V
-		$\dot{V}_D = 12 \text{ V; } I_T = 0.1 \text{ A}$ $\dot{V}_D = 400 \text{ V; } I_T = 0.1 \text{ A; } T_i = 125$	°C	0.25	0.4	-	V
I_D	Off-state leakage current	$V_D^2 = V_{DRM(max)}$; $T_j = 125 °C$		-	0.1	0.5	mΑ

DYNAMIC CHARACTERISTICS

T_i = 25 °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
dV _D /dt	Critical rate of rise of	$V_{DM} = 67\% V_{DRM(max)}; T_j = 125 °C;$	1000	4000	-	V/μs
	off-state voltage Critical rate of change of commutating current	exponential waveform; gate open circuit $V_{DM} = 400 \text{ V}$; $T_j = 125 ^{\circ}\text{C}$; $I_{T(RMS)} = 25 \text{A}$; without snubber; gate open circuit	-	44	-	A/ms
t _{gt}	Gate controlled turn-on time	$I_{TM} = 30 \text{ A}$; $V_D = V_{DRM(max)}$; $I_G = 0.1 \text{ A}$; $dI_G/dt = 5 \text{ A}/\mu\text{s}$	-	2	-	μs

September 1997 3 Rev 1.200

² Device does not trigger in the T2-, G+ quadrant.

NXP Semiconductors Product specification

Three quadrant triacs high commutation

BTA225 series B

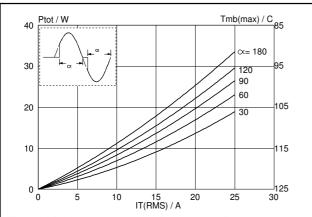


Fig.1. Maximum on-state dissipation, P_{tot} , versus rms on-state current, $I_{T(RMS)}$, where α = conduction angle.

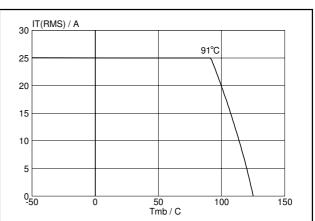


Fig.4. Maximum permissible rms current $I_{T(RMS)}$, versus mounting base temperature T_{mb} .

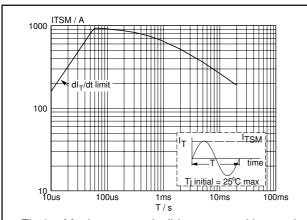


Fig.2. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus pulse width t_p , for sinusoidal currents, $t_p \le 20$ ms.

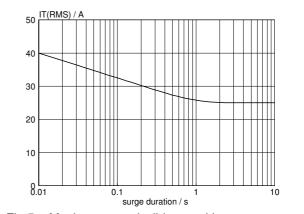


Fig.5. Maximum permissible repetitive rms on-state current $I_{T(RMS)}$, versus surge duration, for sinusoidal currents, f = 50 Hz; $T_{mb} \le 91$ °C.

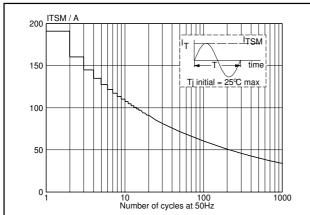


Fig.3. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus number of cycles, for sinusoidal currents, f = 50 Hz.

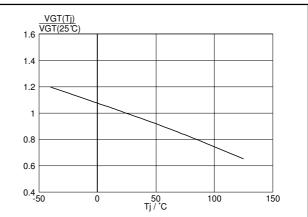
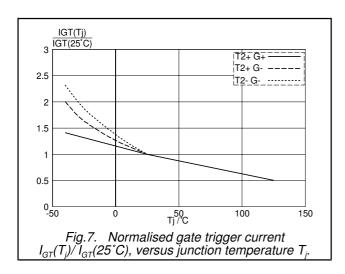


Fig.6. Normalised gate trigger voltage $V_{GT}(T_j)/V_{GT}(25^{\circ}C)$, versus junction temperature T_j .

NXP Semiconductors Product specification

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BTA225 series B



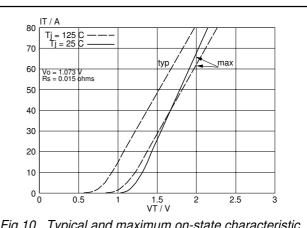
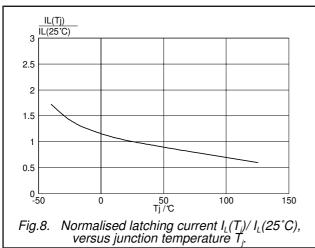
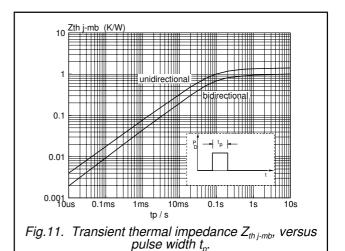
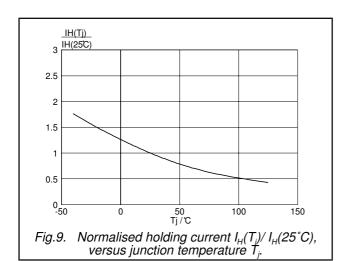


Fig.10. Typical and maximum on-state characteristic.







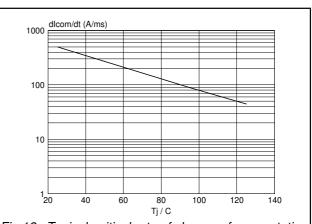


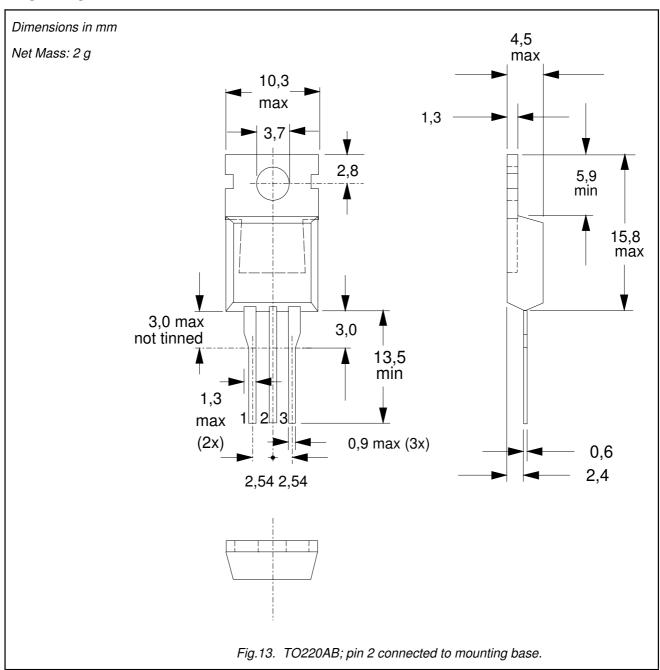
Fig.12. Typical, critical rate of change of commutating current dl_{com}/dt versus junction temperature.

NXP Semiconductors Product specification

Three quadrant triacs high commutation

BTA225 series B

MECHANICAL DATA



Notes

- Refer to mounting instructions for TO220 envelopes.
 Epoxy meets UL94 V0 at 1/8".

Legal information

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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